

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/051,264 | Applicant(s)/Patent Under Reexamination SCOTT ET AL. | |
| | Examiner Alan S Chen | Art Unit 2182 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| | A | US-2003/0120849 A1 | 06-2003 | Roslak et al. | 710/303 |
| | B | US-5,489,773 A | 02-1996 | Kumar, Rajendra | 235/380 |
| | C | US-2003/0142089 A1 | 07-2003 | Myers, Robert L. | 345/213 |
| | D | US-5,278,730 A | 01-1994 | Kikinis, Dan | 361/686 |
| | E | US-5,396,400 A | 03-1995 | Register et al. | 361/686 |
| | F | US-5,581,766 A | 12-1996 | Spurlock, Randolph W. | 713/2 |
| | G | US-6,101,087 A | 08-2000 | Sutton et al. | 361/686 |
| | H | US-2003/0145148 A1 | 07-2003 | Zhang et al. | 710/305 |
| | I | US-6,744,740 B2 | 06-2004 | Chen, Priscilla | 370/255 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.